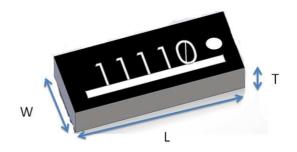
# DATA SHEET

永昀科技股份有限公司

# 5220 Chip antenna

# For Bluetooth / WLAN Applications



P/N: WAN5220D245M04

	Dimension (mm)
L	5.20 ± 0.10
W	2.12 ± 0.10
Т	1.05 ± 0.10

## 1. Electrical Specification

Specification					
Part Number	WAN5220D245M04				
Central Frequency	2450	MHz			
Bandwidth	100 (Min.)	MHz			
Return Loss	-10 (Max)	dB			
Peak Gain	1.57	dBi			
Impedance	50	Ohm			
Operating Temperature	-40∼+85	$^{\circ}\! C$			
Maximum Power	4	W			
Resistance to Soldering Heats	10 ( @ 260°C )	sec.			
Polarization	Linear				
Azimuth Beamwidth	Omni-directional				
Termination	Ni / Sn (Leadless)				

Remark: Bandwidth & Peak Gain was measured under evaluation board of page2

#### **Part Number Information**

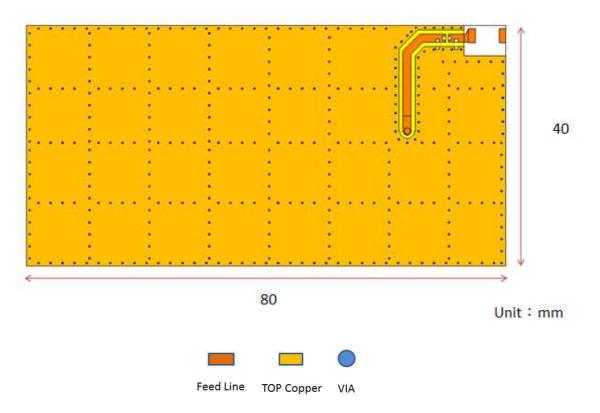
Α	<b>Product Series</b>	Antenna
В	Dimension L x W	5.2X2.0mm (+-0.2mm)
С	Material	High K material
D	Working Frequency	2.4 ~ 2.5GHz
E	Feeding mode	Monopole & Single Feeding
F	Antenna type	Type 04



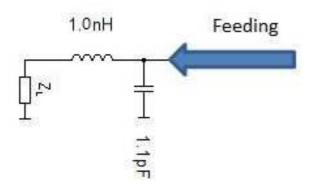


#### 2. Recommended PCB Pattern

#### **Evaluation Board Dimension**



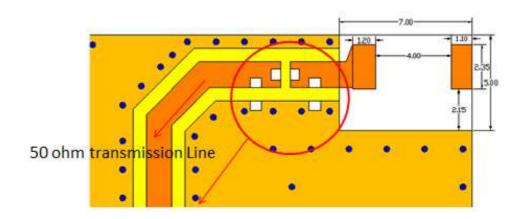
## **Suggested Matching Circuit**





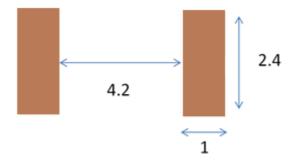


## Layout Dimensions in Clearance area( Size=7.0\*5.0mm)



Matching Circuit

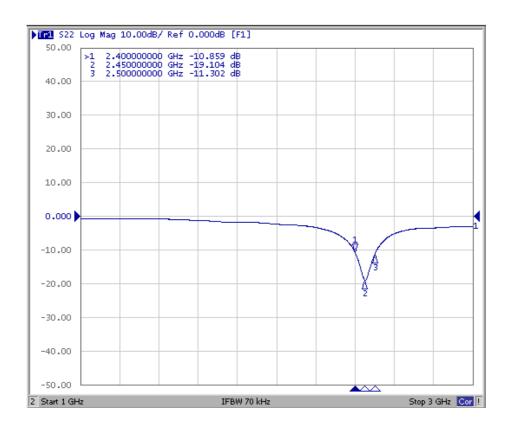
#### (Unit:mm) **FootPrint**





#### 3. Measurement Results

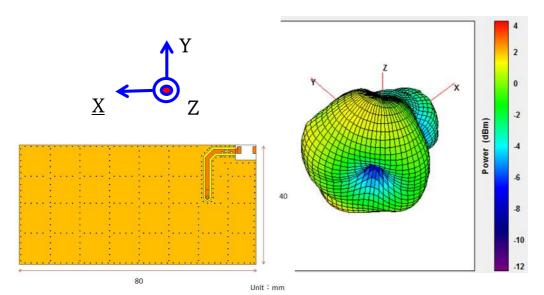
#### **Return Loss**





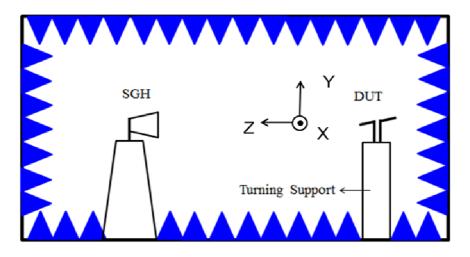


#### **Radiation Pattern**



	Efficiency	Peak Gain	Directivity
2400MHz	55.56 %	0.57 dBi	4.13 dBi
2450MHz	70.58 %	1.79 dBi	4.03 dBi
2500MHz	57.13 %	1.26 dBi	4.11 dBi

## **Chamber Coordinate System**







# 4. Reliability and Test Condictions

ITEM	REQUIREMENTS	TEST CONDITION			
Solderability	1. Wetting shall exceed 90% coverage	✓ Pre-heating			
	2. No visible mechanical damage	temperature:150°C /60sec.			
	ТЕМР	✓ Solder temperature:230±5°C			
	d+1 sec	✓ Duration:4±1sec.			
	230	✓ Solder:Sn-Ag3.0-Cu0.5			
	150°C	✓ Flux for lead free: rosin			
Solder heat	1. No visible mechanical damage	✓ Pre-heating			
Resistance	2. Central Freq. change :within ± 6%	temperature:150°C /60sec.			
	TEMP (C)	✓ Solder temperature:260±5°C			
	260°C 10±0.5 sec.	✓ Duration:10±0.5sec.			
	2000	✓ Solder:Sn-Ag3.0-Cu0.5			
	150°C	✓ Flux for lead free: rosin			
Component	1. No visible mechanical damage	The device should be reflow			
Adhesion		soldered(230 $\pm$ 5 $^{\circ}$ C for 10sec.) to			
(Push test)		a tinned copper substrate A			
		dynometer force gauge should be			
		applied the side of the			
		component. The device must			
		with-ST-F 0.5 Kg without failure of			
		the termination attached to			
		component.			
Component	1. No visible mechanical damage	✓ Insert 10cm wire into the			
Adhesion		remaining open eye			
(Pull test)		bend ,the ends of even wire			
		lengths upward and wind			
		together.			
		✓ Terminal shall not be			
		remarkably damaged.			





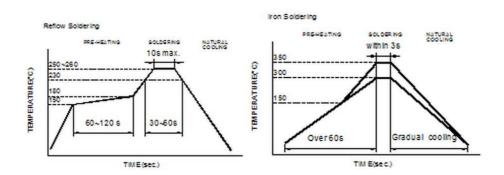
Thermal	No visible mechanical damage				+85°C=>30±3min		
shock	2. Central Freq. change :within ±6%				-40°C =>30±3min		
	Phase	e Temperature(°C) Time(min)		✓	Test cycle:10 cycles		
	1	+85±5℃ 30±3		✓	The chip shall be stabilized		
	2	Room Temperature	Within 3sec		at normal condition for		
	3	-40±2°C	30±3		2~3 hours before measuring.		
	4	Room Temperature	Within 3sec				
Resistance	1. No visi	ble mechanical dam	age	✓	Temperature: 85±5°C		
to High	2. Centra	l Freq. change :withi	n ±6%	✓	Duration: 1000±12hrs		
Temperature	3. No disconnection or short circuit.			✓	The chip shall be stabilized		
				at normal condition for			
					2~3 hours before measuring.		
Resistance	No visible mechanical damage			<b>✓</b>	Temperature:-40±5°C		
to Low	2. Central Freq. change :within ±6%			✓	Duration: 1000±12hrs		
Temperature	3. No disconnection or short circuit.			✓	The chip shall be stabilized		
					at normal condition for		
					2~3 hours before measuring.		
Humidity	1. No visi	No visible mechanical damage		No visible mechanical damage		<b>✓</b>	Temperature: 40±2°C
	2. Centra	2. Central Freq. change :within ±6%			Humidity: 90% to 95% RH		
	3. No disc	. No disconnection or short circuit.			Duration: 1000±12hrs		
				✓	The chip shall be stabilized		
					at normal condition for		
					2~3 hours before measuring.		





#### 5. Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.



Recommended temperature profiles for re-flow soldering in Figure 1.

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

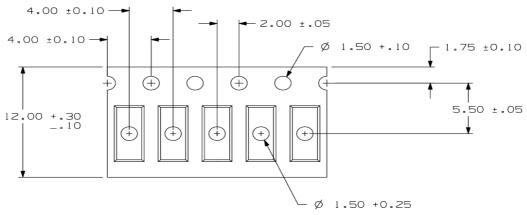
- Preheat circuit and products to 150°C
- · Never contact the ceramic with the iron tip
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280°C tip temperature (max)
- 1.0mm tip diameter (max)
- · Limit soldering time to 3 sec.

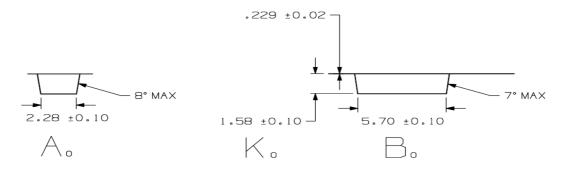




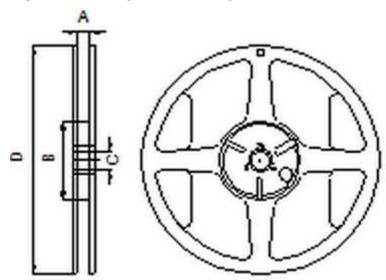
## 6. Packaging Information

## **◆** Tape Specification:





### Reel Specification: (7", Φ180 mm)



Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
12	12±1.0	60±2	13.5±0.5	178±2	2000





### 7. Storage and Transportation Information

#### **Storage Conditions**

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40°C and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

#### **Transportation Conditions**

- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.





### 8. Revision Table

Revision	Date	Content	Remark
V1	9 <sup>th</sup> ,Dec, 2013	New issued	

